

Product Specification

USB Connector, Series A, DIP Type

1. SCOPE

1.1. Contents

This specification covers the performance, tests and quality requirements for the TE Connectivity **USB Connector, Series A, DIP Type**.

1.2. Qualification

When tests are performed on the subject product line, the procedures specified in Figure 1 shall be used. All inspections shall be performed using the applicable inspection plan and product drawing.

2. APPLICABLE DOCUMENT

The following documents form a part of this specification to the extent specified herein. Unless otherwise specified, the latest edition of the document applies. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

2.1. TE Electronics Documents

- 109-197 : Test Specification (AMP test Specifications vs EIA and IEC Test Methods)
- TEC-109-201: Component Heat Resistance to Lead-Free Reflow Soldering.
- 501-11800 : Test Report

2.2. Industry Standard

- EIA-364 : Electrical Connector/Socket Test Procedures Including Environmental Classifications.
- JESD22-B102D: Solderability Test Method.

3. REQUIREMENTS

3.1. Design and Construction

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

3.2. Materials

Materials used in the construction of product shall be as specified on the applicable product drawing.

3.3. Ratings

- Voltage : 30 VAC rms
- Current : 1.5A Max.
- Temperature : 55°C to 85°C

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3.4. Performance and Test description

The product is designed to meet the electrical, mechanical and environmental performance requirements specified in Figure 1. Unless otherwise specified, all tests shall be performed at ambient environmental conditions per EIA-364.

3.5. Test Requirements and Procedures Summary

TEST ITEM		REQUIREMENT	PROCEDURE			
1	Examination of Product	Meets requirements of product drawing. No physical damage.	Visual inspection.			
	ELECTRICAL REQUIREMENT					
2 Low Level Contact		30 mΩ Max. (Initial)	Subject mated contacts assembled in housing.			
Resistance	30 mΩ Max. (Final)	Open circuit at 20mV Max, 100mA Max. EIA-364-23C, Figure 3				
			500 VAC for 1minute			
3 Dielectric Withstanding Voltage	No creeping discharge or flashover shall occur.	Test between adjacent circuits of unmate connector.				
		Current leakage: 0.5 mA Max.	EIA-364-20C, Method B, Condition II			
			Impressed voltage 500 VDC.			
4 Insulation Resistance	Insulation Resistance	1,000 MΩ Min. (Initial) 1,000 MΩ Min. (Final)	Test between adjacent contacts of unmate connector for 1 minutes.			
			EIA-364-21C.			
5 Temperature Rising		$30^\circ \!\!\! \mathbb{C}$ Max. Under loaded rating current.	Contact series-wired, apply test current of loaded rating current to the circuit, and measure the temperature rising by probing on soldered areas of contacts, after the temperature becomes stabilized deduct ambient temperature from the measured value.			
			EIA-364-70B, Figure-4			
	MECHANICAL REQUIREMENT					
			Operation Speed : 12.5mm/min.			
6 Mati	Mating Force	35 N (3.56 Kgf) Max.	Measure the force required to mate connector.			
			EIA-364-13C			
	Un-mating Force		Operation Speed : 12.5mm/min.			
7		10 N (1.02 Kgf) Min.	Measure the force required to unmate connector.			
			EIA-364-13C			

Figure 1 (Continue)



10Mechanical ShockNo electrical discontinuity greater than 1µ sec shall occur.Waveform : Half-sine shock plus Duration : 11 msec. No. of Drops : 3 drops each to normal reversed directions of X, Y and Z axes,	TEST ITEM	REQUIREMENT	PROCEDURE
9 Vibration No electrical discontinuity greater than 1µ sec shall occur. [See Note 1] Accelerate : 5.35 g's RMS. Duration : 15 minutes in each of three mutually perpendicular planes. EIA-364-28E, Test Condition V, Test Letter A 10 Mechanical Shock No electrical discontinuity greater than 1µ sec shall occur. Accelerate Velocity : 294 m/s2 (30G) Waveform : Half-sine shock plus Duration : 11 msec. 10 Mechanical Shock No electrical discontinuity greater than 1µ sec shall occur. No. of Drops : 3 drops each to normal reversed directions of X, Y and Z axes,			Operation Speed : 500 cycle/hour.
9 Vibration No electrical discontinuity greater than 1µ sec shall occur. Accelerate : 5.35 g's RMS. 9 Vibration Issue in the initial initinitial initiality initial initial initial initial initia	Durability	See Note 1]	Number of cycles : 10,000 cycles
9VibrationNo electrical discontinuity greater than 1μ sec shall occur. [See Note 1]Duration : 15 minutes in each of three mutually perpendicular planes. EIA-364-28E, Test Condition V, Test Letter A0Mechanical ShockNo electrical discontinuity greater than 1μ sec shall occur.Accelerate Velocity : 294 m/s2 (30G) Waveform : Half-sine shock plus Duration : 11 msec. No. of Drops : 3 drops each to normal reversed directions of X, Y and Z axes,			EIA-364-09C
9 Vibration than 1μ sec shall occur. [See Note 1] mutually perpendicular planes. EIA-364-28E, Test Condition V, Test Letter A 10 Mechanical Shock No electrical discontinuity greater than 1μ sec shall occur. Accelerate Velocity : 294 m/s2 (30G) Waveform : Half-sine shock plus Duration : 11 msec. 10 Mechanical Shock No electrical discontinuity greater than 1μ sec shall occur. No. of Drops : 3 drops each to normal reversed directions of X, Y and Z axes,			Accelerate : 5.35 g's RMS.
Image:	Vibration		
10Mechanical ShockNo electrical discontinuity greater than 1µ sec shall occur.Waveform : Half-sine shock plus Duration : 11 msec. No. of Drops : 3 drops each to normal reversed directions of X, Y and Z axes,		See Note 1]	EIA-364-28E,
10Mechanical ShockNo electrical discontinuity greater than 1µ sec shall occur.Duration : 11 msec.No. of Drops : 3 drops each to normal reversed directions of X, Y and Z axes,			Accelerate Velocity : 294 m/s2 (30G)
10No electrical discontinuity greater than 1µ sec shall occur.No. of Drops : 3 drops each to normal reversed directions of X, Y and Z axes,			Waveform : Half-sine shock plus
10 Mechanical Shock than 1µ sec shall occur. No. of Drops - 3 drops each to normal reversed directions of X, Y and Z axes,			
totally 18 drops.	Mechanical Shock	, .	No. of Drops : 3 drops each to normal and reversed directions of X, Y and Z axes, totally 18 drops.
Passing DC 100mA max. Current durin the test.			Passing DC 100mA max. Current during the test.
EIA-364-27B, Test Condition H.			EIA-364-27B, Test Condition H.
Steam Aging Preconditioning :	Solderability		Steam Aging Preconditioning :
			 Intended for non-tin and non-tin-alloy leadfinishes for 93+3/-5℃ 、1hour±5min.
The inspected area of each lead must have 95% solder coverageJESD22-B102D, Condition A			JESD22-B102D, Condition A
11Solderabilitymust have 95% solder coverage minimum.2. Intended for tin and tin-alloy leadfinis for 93+3/-5°C \$ 8hours±15min.		•	 Intended for tin and tin-alloy leadfinishes for 93+3/-5°C 、8hours±15min.
JESD22-B102D, Condition C			JESD22-B102D, Condition C
Solder pot temperature: 245±5°C, 5sec			Solder pot temperature: 245 \pm 5 $^{\circ}$ C , 5sec.
ENVIRONMENTAL REQUIREMENT			
Mated Connector			Mated Connector
-55+0/-3℃ (30 min.), +85+3/-0℃ (30 m	Thermal Shock		-55+0/-3℃ (30 min.), +85+3/-0℃ (30 min.)
12 Thermal Shock [See Note 1] Perform this cycle, repeat 10 cycles		See Note 1]	
EIA-364-32C, Test condition I			

Figure 1 (Continue)



TEST ITEM		REQUIREMENT	PROCEDURE			
	Humidity		Mated Connector,			
13		[See Note 1]	25 $^\circ\!\!\mathbb{C}$ to 65 $^\circ\!\!\mathbb{C}$, 90% to 98% RH.			
			Perform this cycle, 168 hours.			
			EIA-364-31B, Method III, Test condition A,			
			Mated Connector			
	Temperature Life		85℃, 250 hours.			
14	(Heat Aging)	[See Note 1]	EIA-364-17B, Test condition 3 (w/o electrical load), Test time condition B			
15	5 Salt Spray No detrimental corrosion allowed in contact area and base metal exposed.		Subject mated connectors to $35+/-2$ °C and $5+/-1\%$ salt condition for 48hours. After test, rinse the sample with water and recondition the room temperature for 1 hour.			
			EIA-364-26B			
	Resistance to Reflow Soldering Heat [See Note 2]		Moisture Soak precondition $\div85^\circ\!\!\mathrm{C}$, 85%RH for 168 hours.			
			Pre Heat:150~200°C, 60~180sec.			
			Peak Temp.:260+0/-5°C , 20~40sec.			
		No physical damage shall occur.	Ramp to peak $: 3^{\circ}$ C max. per second			
16			Ramp to cool down $: 6^\circ \! \mathbb{C} $ max. per second			
			Time over liquids (217 $^\circ$ C) \div 60~150 sec			
			Duration: 3 cycles			
			TE spec. 109-201, Test condition B,			
			Refer to Figure 4.			

Figure 1 (End)

- Note 1 : Shall meet visual requirements, show no physical damage, and meet requirement of additional tests as specified in the test sequence in Figure 2
- Note 2 : Resistance to soldering process is indicated on notes of customer drawing. Select the appropriate test type which drawing notes are matched with.



3.6. Product Qualification and Requalification test

	Test Group						
Test or Examination	А	В	С	D	Е	F	G
	Test Sequence (a)						
Examination of Product	1, 9	1, 5	1, 8	1, 3	1, 5	1, 3	1, 3
Contact Resistance	3, 7	2, 4			2, 4		
Dielectric withstanding Voltage			3, 7				
Insulation Resistance			2, 6				
Temperature Rising				2			
Mating Force	2						
Un-mationg Force	8						
Durability	4						
Vibration	6						
Mechanical Shock	5						
Solderability						2	
Thermal Shock			4				
Humidity			5				
Temperature Life		3					
Salt Spray					3		
Resistance to Soldering Heat							2

NOTE: (a) Numbers indicate sequence in which tests are performed.

(${\bf b}\,)\,$ Discontinuities shall not take place in this test group, during tests.

Figure 2



Figure 3. Low Level Contact Resistance

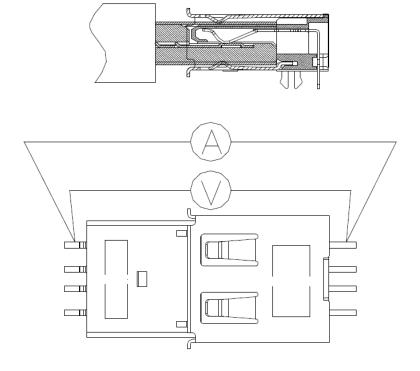


Figure 4. Temperature Profile of Reflow Soldering

